Advances in Data Science and Machine Learning

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Message from the Guest Editors

Dear Colleagues,

The Special Issue on "Advances in Data Science and Machine Learning" aims to provide a platform for researchers to showcase their latest research and findings in the area of data mining and data analysis. Data mining has attracted much attention in the past year and has witnessed considerable advancements. These include new algorithms in data mining; new application areas that data mining could be applied to and make a difference to the domain; and new technologies that enhance the deployment of data mining and analysis instruments.

The Special Issue will cover a wide range of topics related to Data Science and Machine Learning, including, but not limited to, AI algorithms, data collection, data storage, semantics, applications enabled by data mining and analysis, and development environments. Contributions from interdisciplinary teams combining their expertise are encouraged. We also welcome Systematic Survey papers for the latest advancements in the relevant subject areas.

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Special Issue

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Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

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